

December 2011

FDMS8018

N-Channel PowerTrench $^{\! \rm I\!R}$ MOSFET 30 V, 120 A, 1.8 $\, {\rm m}\Omega$

Features

- Max $r_{DS(on)}$ = 1.8 m Ω at V_{GS} = 10 V, I_D = 30 A
- Max $r_{DS(on)} = 2.4 \text{ m}\Omega$ at $V_{GS} = 4.5 \text{ V}$, $I_D = 26 \text{ A}$
- Advanced Package and Silicon combination for low r_{DS(on)} and high efficiency
- Next generation enhanced body diode technology, engineered for soft recovery
- MSL1 robust package design
- 100% UIL tested
- RoHS Compliant

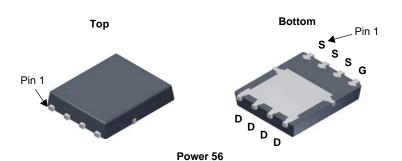


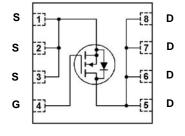
General Description

This N-Channel MOSFET has been designed specifically to improve the overall efficiency and to minimize switch node ringing of DC/DC converters using either synchronous or conventional switching PWM controllers.It has been optimized for low gate charge, low $r_{\rm DS(on)},$ fast switching speed ang body diode reverse recovery performance.

Applications

- VRM Vcore Switching for Desktop and Server
- OringFET / Load Switching
- DC-DC Conversion
- Motor Bridge Switch





MOSFET Maximum Ratings TA = 25 °C unless otherwise noted

Symbol	Parameter		Ratings	Units	
V _{DS}	Drain to Source Voltage			30	V
V _{GS}	Gate to Source Voltage		(Note 4)	±20	V
	Drain Current -Continuous (Package limited)	T _C = 25 °C		120	
	-Continuous (Package limited)	T _C = 100 °C		100	
I_D	-Continuous (Silicon limited)	T _C = 25 °C		174	Α
	-Continuous	T _A = 25 °C	(Note 1a)	30	
	-Pulsed			180	
E _{AS}	Single Pulse Avalanche Energy		(Note 3)	126	mJ
D	Power Dissipation	T _C = 25 °C		83	W
P_{D}	Power Dissipation	T _A = 25 °C	(Note 1a)	2.5	VV
T _J , T _{STG}	Operating and Storage Junction Temperature Ra	ange		-55 to +150	°C

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case	1.5	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	50	C/VV

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMS8018	FDMS8018	Power 56	13 " 12 mm		3000 units

Electrical Characteristics T_J = 25 °C unless otherwise noted

Symbol	Parameter Test Conditions		Min	Тур	Max	Units
Off Chara	cteristics					
BV_{DSS}	Drain to Source Breakdown Voltage	I _D = 250 μA, V _{GS} = 0 V	30			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I _D = 250 μA, referenced to 25 °C		14		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 24 V, V _{GS} = 0 V			1	μΑ
I _{GSS}	Gate to Source Leakage Current, Forward	V _{GS} = 20 V, V _{DS} = 0 V			100	nA

On Characteristics

V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	1.0	1.5	3.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I _D = 250 μA, referenced to 25 °C		-6		mV/°C
		V _{GS} = 10 V, I _D = 30 A		1.5	1.8	
r _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = 4.5 \text{ V}, I_D = 26 \text{ A}$		1.9	2.4	mΩ
, ,		V_{GS} = 10 V, I_D = 30 A, T_J = 125 °C		2.2	2.7	
9 _{FS}	Forward Transconductance	V _{DS} = 5 V, I _D = 30 A		194		S

Dynamic Characteristics

C _{iss}	Input Capacitance	V -45 V V -0 V	3935	5235	pF
C _{oss}	Output Capacitance	V _{DS} = 15 V, V _{GS} = 0 V, f = 1 MHz	1380	1835	pF
C _{rss}	Reverse Transfer Capacitance	1 - 1 WH12	137	210	pF
R_q	Gate Resistance		0.9		Ω

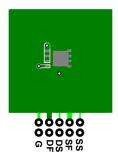
Switching Characteristics

t _{d(on)}	Turn-On Delay Time		15	27	ns
t _r	Rise Time	V _{DD} = 15 V, I _D = 30 A,	7.3	15	ns
t _{d(off)}	Turn-Off Delay Time	V_{GS} = 10 V, R_{GEN} = 6 Ω	38	62	ns
t _f	Fall Time		4.8	10	ns
Q _g	Total Gate Charge	V _{GS} = 0 V to 10 V	58	61	nC
Qg	Total Gate Charge	$V_{GS} = 0 \text{ V to } 4.5 \text{ V}$ $V_{DD} = 15 \text{ V}$,	28	39	nC
Q_{gs}	Gate to Source Charge	I _D = 30 A	10.3		nC
Q_{gd}	Gate to Drain "Miller" Charge		7.7		nC

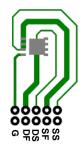
Drain-Source Diode Characteristics

V_{SD}	Source to Drain Diode Forward Voltage	V _{GS} = 0 V, I _S = 2.1 A	(Note 2)	0.67	7 1.1	V
	Source to Drain Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_{S} = 30 \text{ A}$	(Note 2)	0.77	1.2]
t _{rr}	Reverse Recovery Time	I _F = 30 A, di/dt = 100 A/μs		43	69	ns
Q _{rr}	Reverse Recovery Charge			25	40	nC
t _{rr}	Reverse Recovery Time	I _F = 30 A, di/dt = 300 A/μs		34	55	ns
Q _{rr}	Reverse Recovery Charge			46	72	nC

Notes:
1. R_{0,JA} is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{0,JC} is guaranteed by design while R_{0,CA} is determined by the user's board design.



a) 50 °C/W when mounted on a 1 in² pad of 2 oz copper



b) 125 °C/W when mounted on a minimum pad of 2 oz copper.

- 2. Pulse Test: Pulse Width < 300 $\mu\text{s},$ Duty cycle < 2.0%.
- 3. Starting T $_{J}$ = 25 °C; N-ch: L = 0.3 mH, I $_{AS}$ = 29 A, V $_{DD}$ = 27 V, V $_{GS}$ = 10 V.
- 4.As an N-ch device, the negative Vgs rating is for low duty cycle pulse occurrence only. No continuous rating is implied.

Typical Characteristics T_{.1} = 25 °C unless otherwise noted

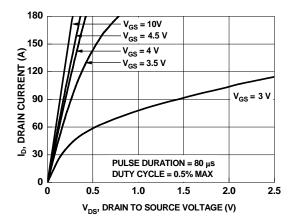


Figure 1. On Region Characteristics

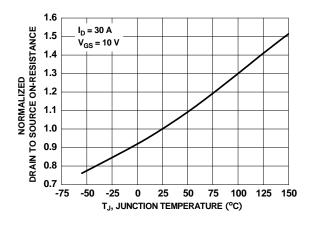


Figure 3. Normalized On Resistance vs Junction Temperature

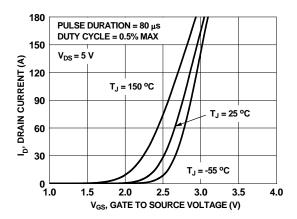


Figure 5. Transfer Characteristics

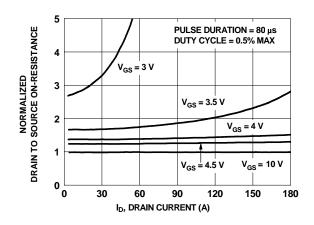


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

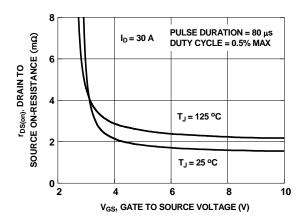


Figure 4. On-Resistance vs Gate to Source Voltage

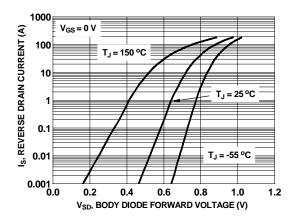


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics $T_J = 25$ °C unless otherwise noted

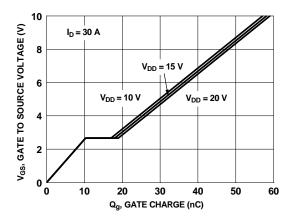


Figure 7. Gate Charge Characteristics

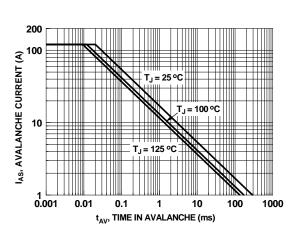


Figure 9. Unclamped Inductive Switching Capability

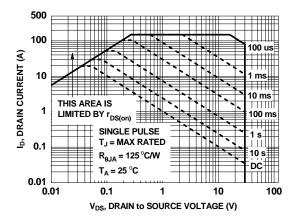


Figure 11. Forward Bias Safe Operating Area

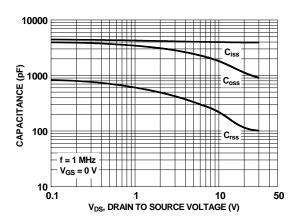


Figure 8. Capacitance vs Drain to Source Voltage

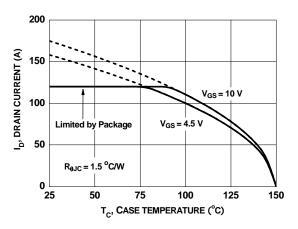


Figure 10. Maximum Continuous Drain Current vs Case Temperature

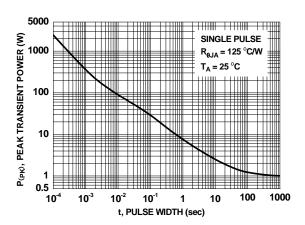


Figure 12. Single Pulse Maximum Power Dissipation

Typical Characteristics $T_J = 25$ °C unless otherwise noted

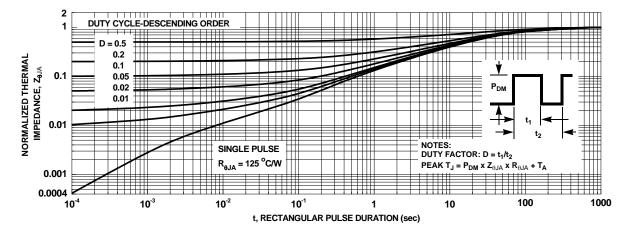


Figure 13. Junction-to-Ambient Transient Thermal Response Curve

Dimensional Outline and Pad Layout A 5.10 1.27 PKG В 8 5 0.77 4.52 KEEP OUT AREA 3.75 PKG & 6.61 PIN #1 IDENT MAY TOP VIEW APPEAR AS OPTIONAL 1.27 SEE DETAIL A LAND PATTERN RECOMMENDATION SIDE VIEW OPTIONAL DRAFT 5.10 4.90 ANGLE MAY APPEAR ON FOUR SIDES 3.81 OF THE PACKAGE 1.27 -0.46 -0.36 (8X) (0.39)⊕ 0.10 M C A B 3 4 (0.52) (0.50) **CHAMFER** (3.40)CORNER (1.81) AS PIN #1 **IDENT MAY** APPEAR AS OPTIONAL <u>†</u> (1.19) - 0.15 MAX (2X) OPTION - B (PUNCHED TYPE) NOTES: UNLESS OTHERWISE SPECIFIED A) PACKAGE STANDARD REFERENCE: **BOTTOM VIEW** JEDEC MO-240, ISSUE A, VAR. AA, DATED OCTOBER 2002. B) ALL DIMENSIONS ARE IN MILLIMETERS. C) DIMENSIONS DO NOT INCLUDE BURRS OR MOLD FLASH. MOLD FLASH OR BURRS DOES NOT EXCEED 0.10MM. // 0.10 C D) DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994 ○ 0.08 C E) IT IS RECOMMENDED TO HAVE NO TRACES Ċ 0.05 0.00 OR VIAS WITHIN THE KEEP OUT AREA. 1.10 0.90 SEATING F) DRAWING FILE NAME: PQFN08AREV6. **PLANE** DETAIL A OPTION - A (SAWN TYPE)





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